

VSTF065R10ANB

Datasheet



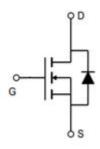


VSTF065R10ANB

General Description

V _{(BR)DSS}	R _{DS(ON)_max}	I_D
650V	100mΩ@10V	47A

Symbol



Symbol of VSTF065R10ANB

Features

- Extremely low switching loss
- Excellent stability and uniformity
- RoHS and Halogen-Free Compliant
- Ultra-fast and robust body diode

Application

- PC power
- LED lighting
- Telecom power
- Server power
- Solar/UPS

Package Type



TO-247

Package Type of VSTF065R10ANB

Ordering Information

Product Name	Package	Marking			
VSTF065R10ANB	TO-247	VSTF065R10ANB			



VSTF065R10ANB

Absolute Maximum Ratings(T_J= 25 °C, unless otherwise specified)

Parameter	Symbol	Rating	Unit	
Drain-Source Voltage		V_{DS}	650	V
Gate-Source Voltage		V_{GS}	±30	V
Continuous Drain Current Note 1	$T_C=25^{\circ}C$	I_D	47	A
Pulsed Drain Current Note 2	$T_C=25$ °C	I _{D, pulse}	141	A
Continuous Diode Forward Current Note 1	$T_C=25^{\circ}C$	I_S	47	A
Diode Pulsed Current Note 2	$T_C=25^{\circ}C$	I _{S, pulse}	141	A
Max Power Dissipation Note 3	$T_C=25^{\circ}C$	P_{D}	658	W
Avalanche Current, Single Pulse Note 4		I _{AS}	8.5	A
Avalanche Energy, Single Pulse Note4		Eas	2168	mJ
MOSFET dv/dt ruggedness, V _{DS} =0~480V		dv/dt	50	V/ns
Reverse diode dv/dt, V _{DS} =0~480V, I _{SD} <= I _D	dv/dt	15	V/ns	
Operation and storage temperature		T _J ,T _{STG}	-55 to 150	°C

Thermal Resistance

Parameter	Symbol	Min	Тур	Max	Unit
Thermal Resistance, Junction-to-Case	$R_{ heta JC}$	-	0.19	-	°C/W
Thermal Resistance, Junction-to-Ambient Note5	$R_{ heta JA}$	-	62.5	-	C/W

Notes:

Note1: Calculated continuous current based on maximum allowable junction temperature.

Note2: Pulse width limited by safe operating area.

Note3: Based on max. junction temperature, using junction-case thermal resistance.

Note4: $V_{DD}=100V$, $V_{GS}=10V$, L=60mH, starting $T_A=25$ °C.

Note5: When mounted on 1 inch square copper board, t≤10sec. The value in any given application depends on the user's specific board design.



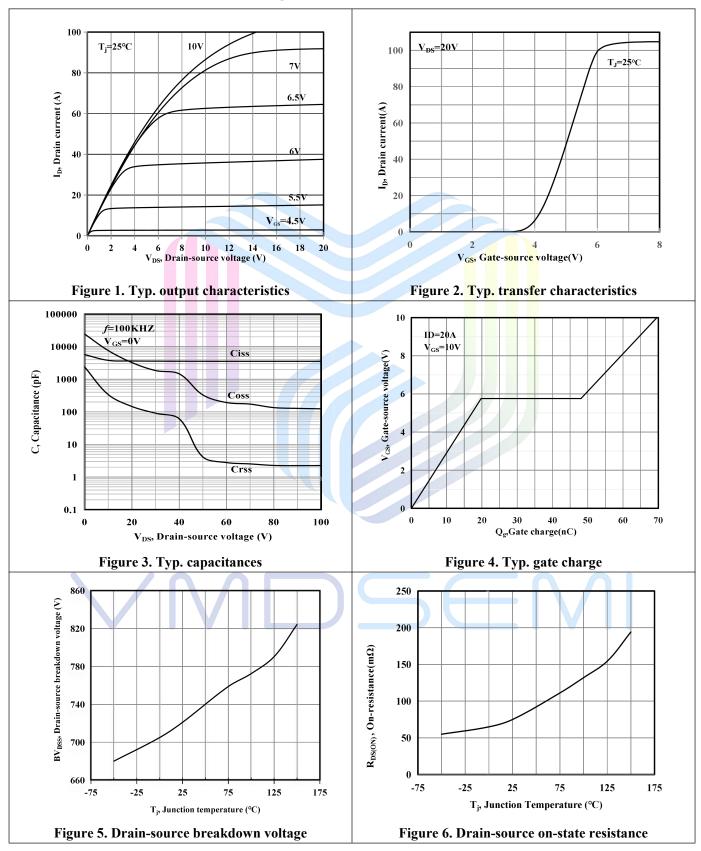
VSTF065R10ANB

Electrical Characteristics (T_J= 25 °C, unless otherwise specified)

Parameter		Symbol	Test Conditions	Min	Тур	Max	Unit
Statistic Characteristics							
Drain-Source Breakdown Voltage		$\mathrm{BV}_{\mathrm{DSS}}$	V _{GS} =0V, I _D =250uA	650	-	-	V
Drain-Source Leakage Current		I_{DSS}	V _{DS} =650V, V _{GS} =0V	-	-	10	uA
Gate-Source Leakage Current	Forward	I_{GSSF}	$V_{GS}=30V, V_{DS}=0V$ -		-	100	n 1
	Reverse	I_{GSSR}	V_{GS} =-30V, V_{DS} =0V	-	-	-100	nA
Gate Threshold Voltage		$V_{\text{GS(TH)}}$	$V_{DS}=V_{GS}$, $I_{D}=250uA$	3.0	4.0	5.0	V
Drain-Source On-State Resistance	ce	$R_{\mathrm{DS}(\mathrm{ON})}$	$V_{GS}=10V, I_{D}=20A$	-	74	100	m Ω
Gate Resistance		R_G	F=1MHz, Open Drain	-	4.2	-	Ω
Dynamic Characteristics							
Input Capacitance			$V_{DS}=50V$		3564	-	pF
Output Capacitance	Output Capacitance		V _{GS} =0V	-	330	-	pF
Reverse Transfer Capacitance		C_{rss}	f=100kHz	-	4.13	-	pF
Turn-on Delay Time		$t_{d(on)}$	V _{DS} =400V	-	23.46	-	
Rise Time		$t_{\rm r}$	I _D =20A	-	10.89	-	12 G
Turn-off Delay Time		$t_{ m d(off)}$	$R_G=2\Omega$	-	58.69	-	ns
Fall Time		$t_{ m f}$	V _{GS} =10V	-	6.21	-	
Gate Charge Characteristics							
Gate to Source Charge	Gate to Source Charge		V_{DS} =400V I_{D} =20A	<i>J</i> - <i>I</i>	19.78	-	nC
Gate to Drain Charge		Q_{gd}		-/-	28.3	-	
Gate Charge Total	Gate Charge Total		$V_{GS}=0$ to $10V$	-	69.6	-	
Gate Plateau Voltage	Gate Plateau Voltage		V GS-0 10 10 V	-	5.76	-	V
Reverse Diode Characteristics							
Drain-Source Diode Forward Voltage		V_{SD}	$V_{GS}=0V$, $I_{S}=1A$	-	0.66	1.4	V
Reverse Recovery Time		t_{rr}	V _R =400V	-	137	-	ns
Reverse Recovery Charge		Qrr	$I_S=20A$	-	855	-	nC
Peak Reverse Recovery Current		I _{rrm}	di/dt=100A/us		11.4	1-1	A



Electrical Characteristics Diagrams





VSTF065R10ANB

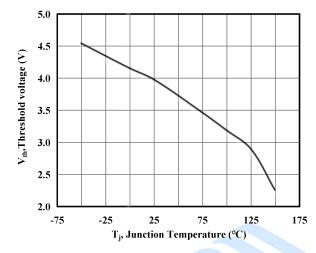


Figure 7. Threshold voltage

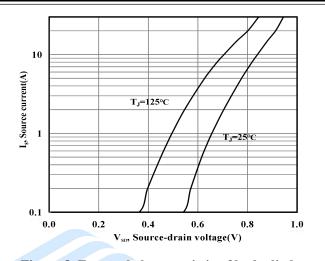


Figure 8. Forward characteristic of body diode

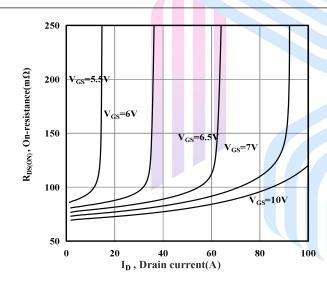


Figure 9. Drain-source on-state resistance

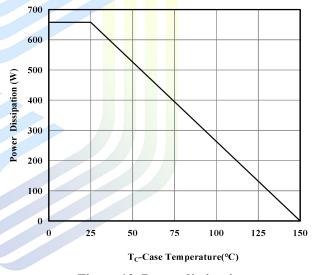
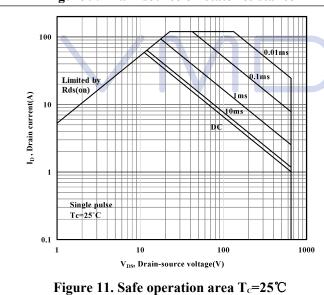


Figure 10. Power dissipation

1.000



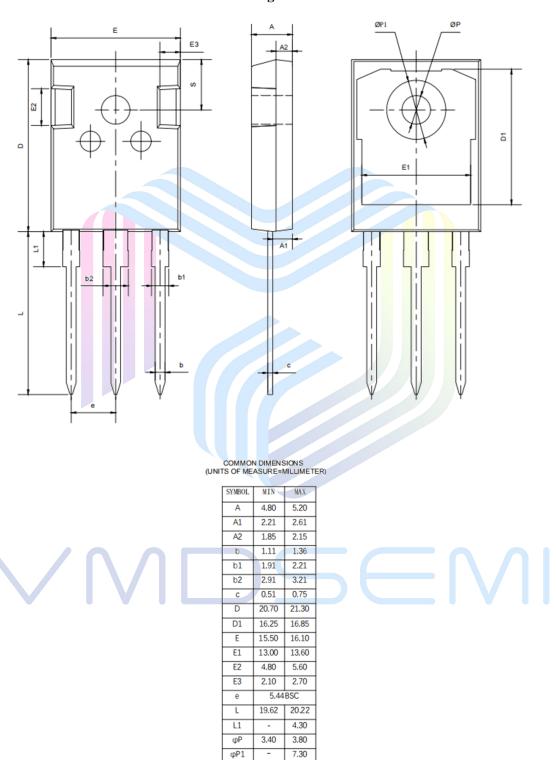
0.001 0.001 0.002 0.001 0.002 0.002 0.001 0.002 0.002 0.001 0.002 0.002 0.001 0.002 0.002 0.001 0.002

Figure 12. Max. transient thermal impedance



Mechanical Dimensions

TO-247 Package Information



6.15BSC

100mΩ, 650V, N-Channel Power MOSFET

VSTF065R10ANB

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